

FDW2509NZ

Common Drain N-Channel 2.5V Specified PowerTrench^o MOSFET

General Description

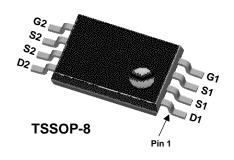
This N-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild's Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V – 12V).

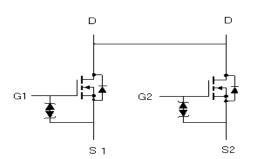
Applications

Li-Ion Battery Pack

Features

- 7.1 A, 20 V. $R_{DS(ON)} = 20 \text{ m}\Omega$ @ $V_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 26 \text{ m}\Omega$ @ $V_{GS} = 2.5 \text{ V}$
- Extended V_{GSS} range (±12V) for battery applications
- ESD protection diode (note 3)
- High performance trench technology for extremely low R_{DS(ON)}
- Low profile TSSOP-8 package





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage		±12	
I _D	Drain Current - Continuous	(Note 1a)	7.1	А
	– Pulsed		30	
P _D	Power Dissipation for Single Operation	(Note 1a)	1.6	W
		(Note 1b)	1.1	
T_J , T_{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

R _{θJA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	77	°C/W
		(Note 1b)	114	

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
2509NZ	FDW2509NZ	13"	12mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	ecteristics		•		•	•
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	20			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to 25°C		11		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			± 10	μΑ
On Chara	cteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.6	0.8	1.5	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu A$, Referenced to $25^{\circ}C$		-3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 7.1 \text{ A}$ $V_{GS} = 2.5 \text{ V}, I_D = 6.2 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 7.1 \text{ A}, T_J = 125 ^{\circ}\text{C}$		15 18 20	20 26 29	mΩ
I _{D(on)} (Note 4)	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$	30			Α
g FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_{D} = 7.1 \text{ A}$		36		S
Dvnamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$		1263		pF
Coss	Output Capacitance	f = 1.0 MHz		327		pF
C _{rss}	Reverse Transfer Capacitance			179		pF
R _G	Gate Resistance	$V_{GS} = 15 \text{ mV}, f = 1.0 \text{ MHz}$		1.9		Ω
Switching	Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = 10 \text{ V}, I_D = 1 \text{ A},$		11	20	ns
t _r	Turn-On Rise Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$		15	27	ns
t _{d(off)}	Turn-Off Delay Time	7		27	43	ns
t _f	Turn-Off Fall Time			12	22	ns
Qg	Total Gate Charge	$V_{DS} = 10 \text{ V}, I_{D} = 7.1 \text{ A},$		13	19	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 4.5 V		2		nC
Q_{gd}	Gate-Drain Charge			4		nC
Drain-So	urce Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source	Diode Forward Current			1.3	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{S} = 1.3 \text{ A} \text{(Note 2)}$			1.2	V
t _{rr}	Diode Reverse Recovery Time	$I_F = 7.1 \text{ A}, \qquad d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$		20		nS
Q _{rr}	Diode Reverse Recovery Charge	1		14		nC

Notes

- R_{8JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8JC} is guaranteed by design while R_{8CA} is determined by the user's board design.
 - a) $\rm\,R_{\rm \theta JA}$ is 77°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.
 - b) $\rm\,R_{\rm \theta JA}$ is 114 °C/W (steady state) when mounted on a minimum copper pad on FR-4.
- **2.** Pulse Test: Pulse Width < $300\mu s$, Duty Cycle < 2.0%
- $\textbf{3.} \ \text{The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.}$
- 4. $I_{D(0n)}$ parameter is guaranteed by design and will not be subjected to 100% production testing. Please refer to Fig 1 (On-Region Characteristics).

Typical Characteristics

1.6

1.2

-50

R_{DS(ON)}, NORMALIZED DRAIN-SOURCE ON-RESISTANCE $I_D = 7.1A$ $V_{GS} = 4.5V$

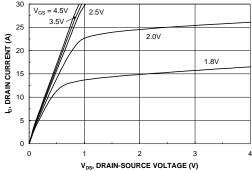


Figure 1. On-Region Characteristics.



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Figure 3. On-Resistance Variation with Temperature.

T_J, JUNCTION TEMPERATURE (°C)

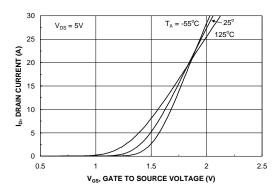


Figure 5. Transfer Characteristics.

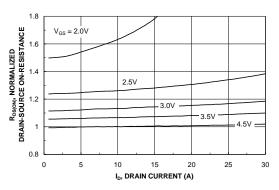


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

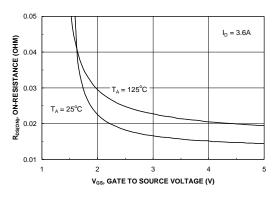


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

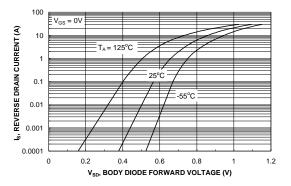
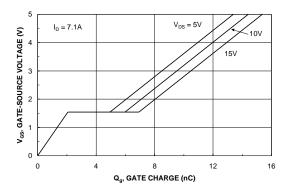


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



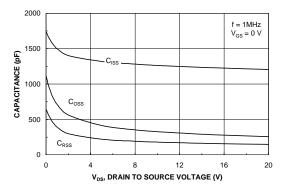


Figure 7. Gate Charge Characteristics.

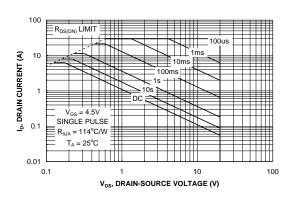


Figure 8. Capacitance Characteristics.

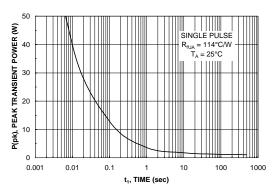


Figure 9. Maximum Safe Operating Area.



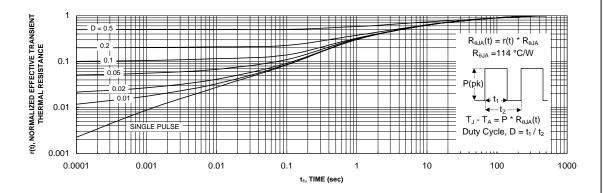


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

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